

**Search Notes**

Application/Control No.

10/715,020

Examiner

Tai Van Nguyen

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	603.07 603.02 603.12 603.14	6/30/2006	TN
	846, 847		
	831		
	Dig. 16		
204	192.34	6/30/2006	TN
	192.32		
360	126, 317		
	322, 320		
	324.12		
216	22, 39	6/30/2006	TN
	48, 49		
<i>Search update</i>			
<i>All above 7/6/06 TN</i>			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
29	<i>All above</i>	<i>7/6/06</i>	<i>TN</i>
204	—	—	—
360	—	—	—
216	—	—	—

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Dexter Tugbang Primary class : 29	6/30/2006	TN
Consuted with Wong Edna Primary class: 204	6/30/2006	TN
Consulted with Alanko Anita Primary class : 216	6/30/2006	TN
East Search	7/6/2006	TN